Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/523,874	LEE ET AL.	
Examiner	Art Unit	
Jafar Parsa	1621	

SEARCHED				
Class	Subclass	Date	Examiner	
562	412	1/16/2006	JP	
562	416	1/16/2006	JP	
		,		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East, West and STN	1/16/2006	JP	
inventor name search	1/16/2006	JP	